

Notice of References Cited

Application/Control No.

09/449,001

Applicant(s)/Patent Under
Reexamination
SENN ET AL.

Examiner

Pablo N Tran

Art Unit

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,064,875	05-2000	Morgan, Joseph LaMance	455/407
	B	US-6,330,443	12-2001	Kirby, Richard Steven	455/406
	C	US-6,308,067	10-2001	Morgan, Joseph LaMance	379/88.02
	D	US-6,314,171	11-2001	Dowens, Jac P.	379/111
	E	US-6,226,364	05-2001	O'Neil, Douglas R.	379/112.01
	F	US-6,208,851	03-2001	Hanson, Daniel A.	455/405
	G	US-6,029,062	02-2000	Hanson, Daniel A.	379/114.17
	H	US-2002/0004380	05-2001	Pedersen et al.	455/406
	I	US-2001/0044293	11-1998	MORGAN, JOSEPH LA MANCE	455/405
	J	US-2001/0041567	12-2000	Morgan, Joseph LaMance	455/433
	K	US-2001/0009849	02-2001	Hanson, Daniel A.	455/408
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	01/49057	07-2000	WO	Aitken et al.	H04Q 7/38
	O	00/70860	11-2000	WO	Raith	H04M 15/28
	P	981211	02-2000	EP	Hui	H04B 7/185
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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